DUAL ENERGY X-RAY DATA ACQUISITION SYSTEM



KEY FEATURES

The XDAS-V3 system is the latest version of Sens-Tech X-ray data acquisition systems. New features include:

- Operation by external trigger
- \bullet 10 μs minimum integration time
- 43 µs minimum scan time for continuous operation
- 16 bit A/D conversion
- Up to 36000:1 SNR
- Programmable dynamic range from 1.875pC to 60pC in steps of 1.875 pC.
 - * 30pC and 60pC using sub-samples
- Gain can be set for each DH board in the system
- Gain for low energy and high energy channels can be set independently
- Programmable bandwidth limiting to reduce noise

- In-system programmable Xilinx FPGA
- Choice of front-lit and back-lit detectors
- Read back of status and configuration parameters
- Programmable integration time in steps of lus
- Separate integration times for low and high energy
- USB 2.0, GigE or parallel interfaces to host
- X-ray energy range 5 keV to 320 keV
 * higher energy range is covered by suitable combination of photodiode and scintillator
- Software API supporting Windows and Linux





DUAL ENERGY X-RAY DATA ACQUISITION SYSTEM

DESCRIPTION

XDAS-V3 is a modular system of boards for data acquisition in X-ray line-scan, multi-view and CT systems. It consists of detector head (DH) boards, signal processing (SP) boards and host interface board.

A single energy DH board has 64 detector channels. A dual energy DH board has 64 low energy channels and 64 high energy channels. Detector boards can be butted end-to-end to form a continuous array over 10 metres in length.

An optional low energy filter is used for enhanced low and high energy separation.

DH boards with 0.4 mm, 0.8 mm and 2.5 mm detector pitch are also available.

APPLICATIONS

- Security inspection
- CT Imaging
- Multi-view imaging
- Non-destructive testing
- Food inspection
- Thickness measurement
- Foreign particle detection
- Bone densitometry

- Industrial process control
- Mineral sorting
- Waste sorting







DUAL ENERGY X-RAY DATA ACQUISITION SYSTEM



GENERAL SPECIFICATION

| INTEGRATION TIME (SINGLE SAMPLE) | INTEGRATION TIME (MULTIPLE SAMPLES) | |
|---|---|--|
| 10 μs to 50 ms | 200 ms (max) | |
| SUB-SAMPLES | POWER SUPPLY INTERFACE BOARD | |
| 1, 2 or 4 | 12V (9V to 30V), 100 mVp-p ripple | |
| CROSS-TALK (BOARD TO BOARD) | CURRENT (TYPICAL) | |
| <0.01% | DH: 125 mA to 150mA | |
| CROSS-TALK (CHANNEL TO CHANNEL) | SP: 200mA to 900mA | |
| <0.1% | Interface board: 100mA to 500mA | |
| DATA RATE (MAXIMUM) 48 MB/s | SNR* (ELECTRONIC) 3.75pC 14500:1 | |
| NON-LINEARITY <0.1% | 15pC 19000:1 60pC 36000:1 | |
| A/D CONVERSION 16 bits | SNR* (<30PF DETECTOR CAPACITANCE) 3.75pC 8000:1 | |
| DATA OUTPUT 16 bits | 15pC 17500:1 60pC 33000:1 | |
| DETECTOR PITCH (MM) | NUMBER OF CHANNELS | |
| 1.6 mm | up to 21504 | |
| NUMBER OF SP BOARDS | NUMBER OF DH BOARDS | |
| up to 7 | up to 168 | |

Note 1: Interface board steps down input supply to 6V (max 5A) for SP boards. SP boards provides power to DH boards.

Note 2: SNR is calculated for ADC full scale and bandwidth limiting enabled.

DUAL ENERGY X-RAY DATA ACQUISITION SYSTEM



ENVIRONMENTAL SPECIFICATION

+70 °C

| TEMPERATURE | | |
|-------------|--------------|--|
| Operating | 0 to +60 °C | |
| Storage | -40 °C to +7 | |

HUMIDITY (NON-CONDENSING)Operating30°C 93%Non-operating40°C 93%

PRINCIPLES OF OPERATION

Current from the photodiodes is integrated by an ASIC containing 128 charge sensitive amplifiers. **See detector head block diagram**. Correlated double sampling is used to minimise low frequency noise and reject offset error. The microcircuit provides a multiplexed serial analogue output to the signal processing board where data is converted into 16-bit format. Operation is continuous with one set of data being read out whilst the next set is acquired. Dead time is 1.6 µs at full bandwidth.

The dynamic range of the system is programmable for each DH board and is determined by the storage capacitors within the ASIC. These can be set from 1.25 pF to 10 pF in steps of 1.25 pF, providing charge storage of 1.875 pC to 15 pC in 1.875 pC steps. The dynamic range can be set separately for high and low energy channels.

See system configuration block diagrams, page 11

Multiple sampling facility is available on the SP board. This enables 2 or 4 samples to be added providing a maximum dynamic range of 60 pC.

Integration time can be adjusted in 1µs steps. Low and high energy detectors can be set different integration times enabling fine tuning of the dynamic range for the two detectors.

The operation of the system is controlled by a gate array which provides central intelligence and control signals for signal processing. Control settings are transmitted to the SP board via a serial, USB or GIGE interface. All settings can be stored in non-volatile RAM such that on power-on, the system is initiated in the last mode saved. **See signal processing block diagram**.

DUAL ENERGY X-RAY DATA ACQUISITION SYSTEM

PRINCIPLES OF OPERATION

See system configuration block diagrams, page 11

A system is assembled by interconnecting multiple DH and SP boards and connecting to a processor via an interface adaptor board. The system data rate (host speed) is programmable from 3.0 to 48 MB/s. See system block diagram.

DATA ACQUISITION RATE AND POWER

Signal integration time in a typical line scan application is as calculated using following formula:

Integration time (ms) = pixel width (mm)/belt speed (m/s)

Example: integration time setting for 1.6mm pixel width scanning at 1m/s belt speed shall be 1.6 / 1 = 1.6 ms

Speed of operation is normally limited by processing speed of an SP board. Two speeds are available. The SP board takes 42.7 µs at 3MSps and 85.4 µs at 1.5MSps to process a DH board. Minimum continuous integration time of a system can be calculated using following formula:

3MSps: Tint (minimum) = 1.6μ s + (num DH per SP x 42.7 μ s) 1.5MSps: Tint (minimum) = 3.2μ s + (num DH per SP x 85.4 μ s)

Example: minimum integration time for a 9 DH board and 1 SP board system shall be 1.6 + 9x42.7 = 386 µs Multiple SP boards process DH boards in parallel.

Example: minimum integration time for a 18 DH board and 2 SP board system shall be 1.6 + $\frac{18}{2}$ x 42.7 = 386 µs

Shorter integration time setting will switch electronics to a non-continuous mode. The SP board increases dead time to allow for ADC conversion to complete before starting the next integration cycle.

A total of 258 bytes is read out per DH board. This includes 2 bytes per pixel and 2 header bytes representing SP address and DH address. There are five host bus speed settings avail-able: 3, 6, 12, 24 and 48 MB/s. The host data rate setting must exceed the data being produced by the system. When integration time is longer than Tint (minimum), average host data rate can be calculated using following formula:

Data rate (MB/s) = (258 x numSP X numDH per SP) / Tint (us)

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DUAL ENERGY X-RAY DATA ACQUISITION SYSTEM



DATA ACQUISITION RATE AND POWER

Example: data rate for a system of 2 SP boards and 9 DH boards at 500us integration time shall be (258 x2x9) / 500 = 9.3MB/s. Therefore, host bus speed should be set to 12MHz.

Example: current requirement for a system of 2 SP boards, 18 DH boards and 1 interface board shall be: $(2 \times 900 \text{mA})+(18 \times 150 \text{mA})+(1 \times 500 \text{mA}) = 5\text{A}.$

HOST DATA INTERFACE

Four types are available, providing the following interfaces.

1.

Parallel RS485 output using up to 50 metre SCSI cable connecting to:

- USB 2.0 converter
- GIGE converter
- PCI7300 card, via an RS485 to TTL converter

3.

Local GIGE output connecting to:

- laptop, PC or a single board computer
- UDP protocol over 1000 BASE-T data link

4.

Channel Link (Camera Link)

- 2.2 Gb/s data rate
- Interface to Active Silicon AS-PHX-D48CL-PE4 frame grabber

2.

Local USB 2.0 output connecting to:

- laptop, PC or a single board computer
- USB 2.0 extender using fibre optic or CAT5 cable





EVALUATION SYSTEM

An evaluation system is available, consisting of a detector head board, signal processing board, RS485/USB/GIGE output and evaluation software. This is mounted in a test box (LINX type, see data sheet) to provide electrical and radiation screening.

Demonstration software is available via download link or on a CD or download link and can be loaded on to a Windows PC (Pentium 4 or later) to check basic function of the system. A high speed USB 2.0 or Gigabit Ethernet port is required for the host interface. The software enables setting of gain and integration time and single lines of data to be acquired.

Data can be logged to a csv file and can be displayed in graphical form. Gain and offset correction can be applied via the software.

Imaging Application is available, contact Sens-Tech for details

ORDERING INFORMATION

DETECTORS

Detector selection is an important part of system design. Parameters are stopping power, light output and signal decay time. Fast decay time is particularly important in CT systems.

An overview of typical scintillation materials with the main parameters is presented on page 15.

DUAL ENERGY X-RAY DATA ACQUISITION SYSTEM



ORDERING INFORMATION

DETECTOR HEAD BOARDS

1.6 mm pitch standard width

DETECTOR HEAD BOARDS 1.6 mm pitch narrow width

PART NUMBER DESCRIPTION PART NUMBER DESCRIPTION XDAS-DH3-7000 XDAS-DH3-8000 no detectors no detectors XDAS-DH3-7002 dual energy Gadox & Csl XDAS-DH3-8002 dual energy Gadox & Csl dual energy Gadox & CdWO4 dual energy Gadox & CdWO4 XDAS-DH3-7003 XDAS-DH3-8003 XDAS-DH3-7004 dual energy Csl & Csl XDAS-DH3-8004 dual energy Csl & Csl XDAS-DH3-7005 dual energy fast Gadox & CdWO4 XDAS-DH3-8005 dual energy fast Gadox & CdWO4 XDAS-DH3-7006 dual energy Silicon & Gadox XDAS-DH3-8006 dual energy Silicon & Gadox XDAS-DH3-7007 dual energy Gadox & GOS XDAS-DH3-8007 dual energy Gadox & GOS XDAS-DH3-7011 single energy Gadox XDAS-DH3-8011 single energy Gadox XDAS-DH3-7012 single energy Csl XDAS-DH3-8012 single energy Csl XDAS-DH3-7013 single energy CdWO4 XDAS-DH3-8013 single energy CdWO4 single energy Silicon XDAS-DH3-7014 single energy Silicon XDAS-DH3-8014

XDAS-DH3-8015

XDAS-DH3-7015

single energy GOS

single energy GOS

DUAL ENERGY X-RAY DATA ACQUISITION SYSTEM



ORDERING INFORMATION

SIGNAL PROCESSING BOARD

INTERFACE OPTIONS

| PART NUMBER | DESCRIPTION | PART NUMBER | DESCRIPTION | |
|--------------------------|--|----------------|--|--|
| XDAS-SP3-01 | signal processing board (sandard) | XDAS-485A-V3 | parallel RS485 over 50 way SCSI cable, board only | |
| XDAS-SP3-801 | signal processing board (narrow) | | | |
| TERMINATORS AND ADAPTORS | | XDAS-USB2-1-V3 | USB2 interface with USB connector, power connector and LED | |
| | | XDAS-USB2-2-V3 | USB2 interface board only | |
| PART NUMBER | DESCRIPTION 8 Local bus (standard) | XDAS-USB2-3-V3 | USB2 interface with USB connector LED | |
| XDAS-TERMINATOR | 31 Local bus (narrow) | XDAS-USB2-4-V3 | USB2 interface with USB connector | |
| XDAS-TERMINATOR | 3-01 System bus | XDAS-GIGE-V3 | GIGE interface board only | |
| XDAS-ADAPTOR3-0 | DH3-8xx adaptor to XDAS-SP3-01 (DH1 to 12) | XDAS-GIGE-V3-1 | GIGE interface, with RJ45 connector | |
| XDAS-ADAPTOR3-0 | DH3-8xx adaptor to XDAS-SP3-01 (DH13 to 24) | | and LED | |
| | | XDAS-GIGE-V3-3 | GIGE interface with RJ45 and LED | |
| XDAS-INTERFACE-0 | D1 Belt encoder processing board | XDAS-GIGE-V3-4 | GIGE interface with RJ45 connector | |
| | | XDAS-USB2 | remote RS485 to USB converter | |
| | | XDU-INT-SGI | remote RS485 to GIGE converter | |
| | | | | |

Note: interface boards step down input supply to 6V for supply to SP board (max 5A).

XDAS-V3 1.6 mm pitch data sheet Page 9 of 19

DUAL ENERGY X-RAY DATA ACQUISITION SYSTEM



ORDERING INFORMATION

CABLES

Note: see system configuration section or contact Sens-tech for cable part numbers

| PART NUMBER | DESCRIPTION | PART NUMBER | DESCRIPTION |
|---------------------------|-----------------------------|-------------------------|--|
| Detector board (standard) | 50way 2mm pitch IDC | Detector board (narrow) | 50way 1.27mm pitch IDC |
| CABLE-XDASPCBxx | Data cable (specify length) | Signal processing board | 50way 1.27mm pitch IDC |
| CABLE-XDASPCB21 | 48mm | CABLE-XDASPCBxx | Data cable (specify length) |
| CABLE-XDASPCB22 | 75mm | CABLE-XDASPCB24 | 100mm |
| CABLE-XDASPCB17 | 100mm | CABLE-XDASPCB25 | 175mm |
| CABLE-XDASPCB23 | 110mm | CABLE-XDASPCB26 | 200mm |
| CABLE-XDASPCB18 | 200mm | CABLE-XDASPWR2-xx | Power cable from GIGE board to SP board |
| CABLE-XDASPCB19 | 300mm | | (specify length) |
| CABLE-XDASPCB20 | 400mm | CABLE-XDASPWR2-02 | 500mm |
| | | CABLE-XDASLED-01 | Bulkhead diagnostic LED 20cm |

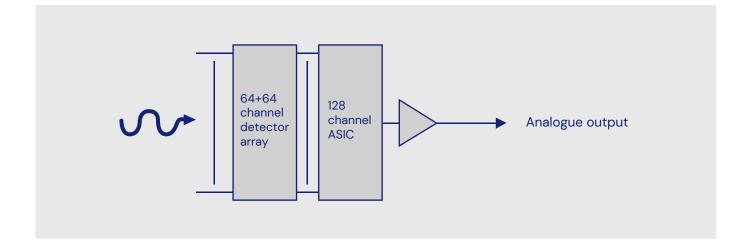
SOFTWARE

| PART NUMBER | DESCRIPTION |
|---------------|-----------------------------|
| XDAS-SOFTWARE | evaluation software and SDK |

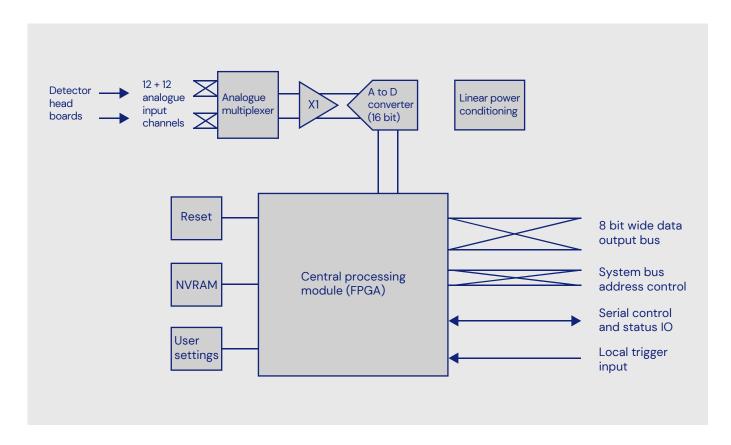


DUAL ENERGY X-RAY DATA ACQUISITION SYSTEM

DETECTOR HEAD BLOCK DIAGRAM



SIGNAL PROCESSING BLOCK DIAGRAM

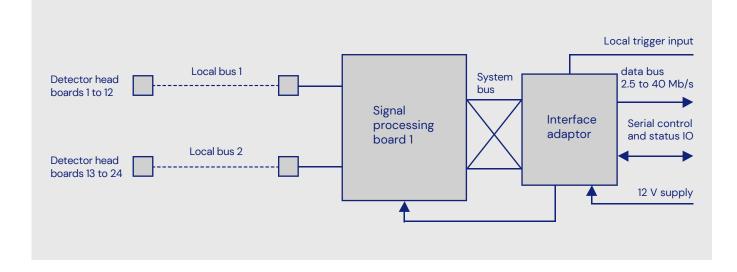


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DUAL ENERGY X-RAY DATA ACQUISITION SYSTEM

SYSTEM BLOCK DIAGRAM

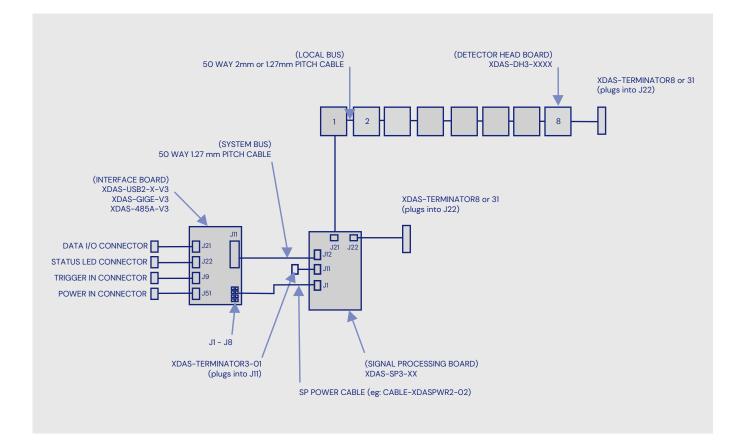




DUAL ENERGY X-RAY DATA ACQUISITION SYSTEM

SYSTEM CONFIGURATION

SINGLE SP BOARD



Notes:-

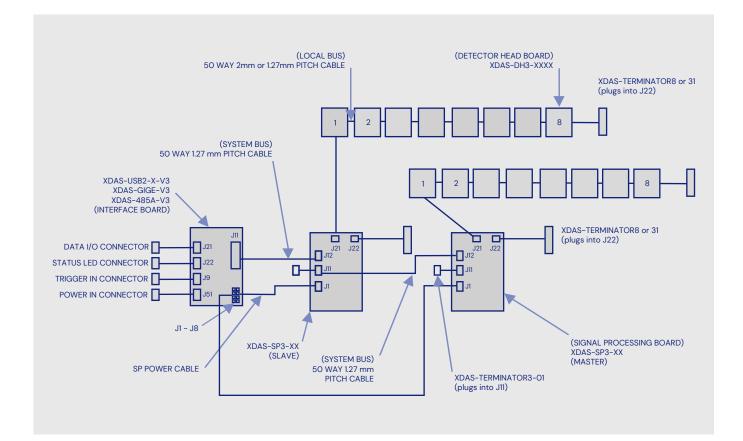
- 1. Custom cable lengths available upon request
- 2. Narrow format boards use 1.27mm pitch connectors and 0.635 mm cable
- 3. Interface boards are supplied with connectors upon request
- 4. XDAS-terminator3-01 is connected to master SP board for systems with multiple SP boards



DUAL ENERGY X-RAY DATA ACQUISITION SYSTEM

SYSTEM CONFIGURATION

MULTIPLE SP BOARD



Notes:-

- 1. Custom cable lengths available upon request
- 2. Narrow format boards use 1.27mm pitch connectors and 0.635 mm cable
- 3. Interface boards are supplied with connectors upon request
- 4. XDAS-terminator3-01 is connected to master SP board for systems with multiple SP boards



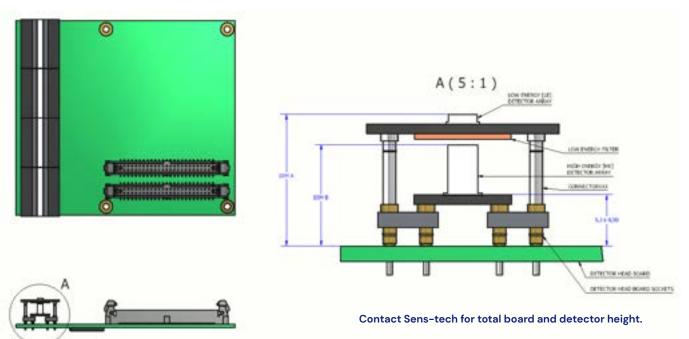


DETECTORS

| TYPE OF SCINTILLATOR | THICKNESS | ENERGY RANGE | SIGNAL OUTPUT PER UNIT ENERGY | DECAY TIME CONSTANT | COMMENTS | FORMAT |
|-------------------------|----------------------------|-----------------|---|--|---|------------------|
| Silicon | 0.15 mm | 5 - 30 keV | highest | 1 µs for unbiased diode | Direct conversion, no scintillator cost | Standard |
| Gadox (Tb) | 0.2 mm 0.3 mm 0.4 mm | 20 - 120 keV | 20% lower similar to CSI 20% higher | <1 ms 2 - 3 ms <1 ms | Phosphor strip | Standard, narrow |
| Csl | 0.4 mm 3 mm 4 mm | 40 - 180 keV | best light output | 2 components, slow decay of secondary component (seconds) | Pixelated arrays to reduce crosstalk | Standard, narrow |
| CdW04 | 2.5 mm | 80 - 320 keV | 25% of CSI | 20 µs | Pixelated arrays, highest cost material | Standard, narrow |
| GOS | 2.9 mm | 80 - 225 KeV | 50% more than CdWO4 at 160keV | 3 µs | Pixelated arrays, resistant to radiation damage | Standard, narrow |

Note 1: Thicknesses shown are of standard products. Other thicknesses are available on order which will cover wide energy ranges Note 2: detector with front lit or back lit photodiodes are available

Note 3: filter thicknesses from 0.1mm to 1.0 mm are available upon request .



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XDAS-V3 1.6 mm pitch data sheet Page 15 of 19

DUAL ENERGY X-RAY DATA ACQUISITION SYSTEM

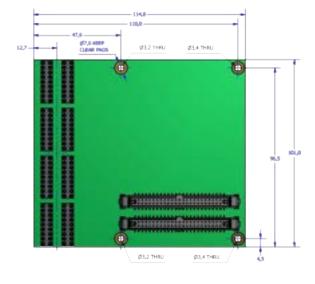


Note: Following drawings are for reference only. Contact Sens-tech for latest mechanical drawings and 3D CAD models.

OUTLINE DRAWINGS

XDAS-DH3-7xx

Standard footprint detector head board (mm)

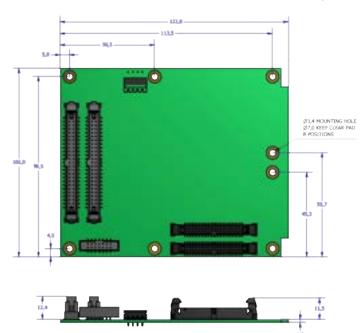






XDAS-SP3-01

Standard footprint signal processing board (mm)





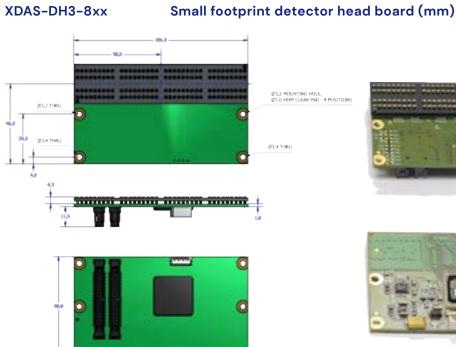
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OUTLINE DRAWINGS CONTINUED...

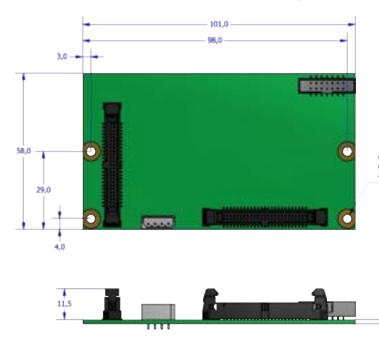






XDAS-SP3-801

Small footprint signal processing board (mm)





Ø3,2 MOUNTING HOLE, Ø7,0 KEEP CLEAR PAD 4 POSITIONS

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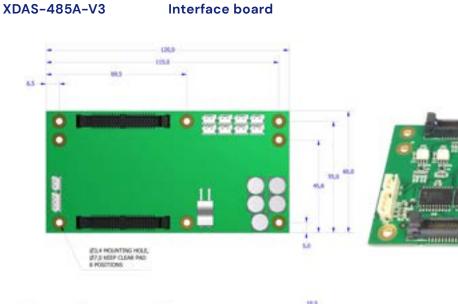
XDAS-V3 1.6 mm pitch data sheet Page 17 of 19

DUAL ENERGY X-RAY DATA ACQUISITION SYSTEM



Note: Following drawings are for reference only. Contact Sens-tech for latest mechanical drawings and 3D CAD models.

OUTLINE DRAWINGS CONTINUED...

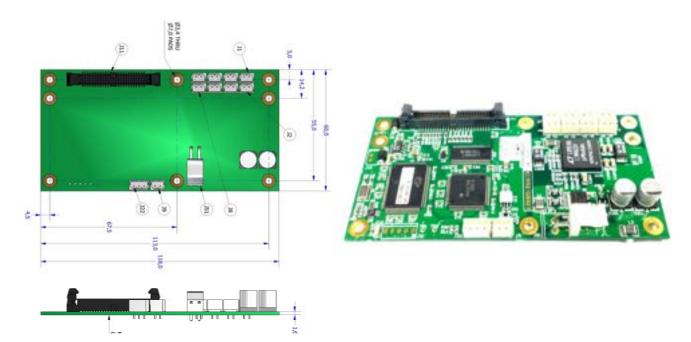






XDAS-USB2-x-V3

Interface board



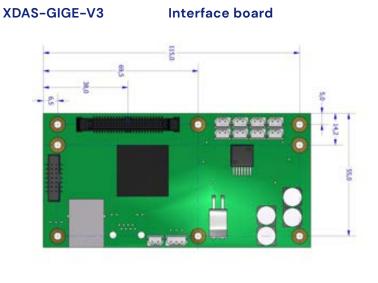
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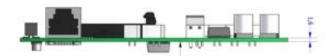


Note: Following drawings are for reference only. Contact Sens-tech for latest mechanical drawings and 3D CAD models.

OUTLINE DRAWINGS CONTINUED...







LED STATUS MNEMONICS

| | LED INDICATION | MEANING (USB) | MEANING (GIGE) |
|--------|-------------------------|---|--|
| | Green | Idle | Idle |
| | Green (Flashing) | Acquiring data | Acquiring data |
| | Amber | Data buffer overflow. (Idle) | Connected to 100Mbps link. Not yet supported |
| \cup | Amber (Flashing) | Data buffer overflow. (Acquiring) | Command received from host |
| | Red/Green (Alternating) | System under reset | System under reset |
| | Red [1] | Microcontroller not responding | Device fault. Contact support |
| | Red [1] (Flashing ~1Hz) | USB endpoint has stalled | Ethernet Link is not connected |
| | Red [1] (Flashing >4Hz) | Could not enumerate as USB2.0 device | Ethernet link fault |
| | Off | Power off, un-programmed or other fault | Power off, un-programmed or other fault |
| | | | |

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XDAS-V3 1.6 mm pitch data sheet Page 19 of 19

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